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CONFIRMATION NO. 4829

SERIAL NUMBER	FILING or 371(c) DATE	CLASS	GROUP ART UNIT	ATTORNEY DOCKET NO.		
10/533,127	10/07/2005	257	2858	ASA-1236		
APPLICANTS Yasumaro Komiya, Yokohama, JAPAN; Shuji Kikuchi, Yokohama, JAPAN; Koichi Uesaka, Yokohama, JAPAN; Tadanobu Toba, Yokohama, JAPAN; Keiichi Yamamoto, Yokohama, JAPAN; ** CONTINUING DATA ***** This application is a 371 of PCT/JP03/13869 10/29/2003 ** FOREIGN APPLICATIONS ***** JAPAN 2002-313618 10/29/2002 ** IF REQUIRED, FOREIGN FILING LICENSE GRANTED **						
Foreign Priority claimed <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	35 USC 119(a-d) conditions met <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	<input type="checkbox"/> Met after Allowance	STATE OR COUNTRY	SHEETS DRAWINGS	TOTAL CLAIMS	INDEPENDENT CLAIMS
Verified and Acknowledged	/VINCENT Q NGUYEN/ Examiner's Signature	Initials	JAPAN	10	17	4
ADDRESS MATTINGLY, STANGER, MALUR & BRUNDIDGE, P.C. 1800 DIAGONAL ROAD SUITE 370 ALEXANDRIA, VA 22314 UNITED STATES						
TITLE Defect analyzing device for semiconductor integrated circuits, system therefor, and detection method						
FILING FEE RECEIVED 1230	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees			
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